

# Detector characterization

- M1: Full specification of a TPA-TCT method for the characterization of irradiated devices (Q4/2018)
- M2: Commissioning of the top-bench fiber-based femto second laser TPA-TCT setup at the SSD/CERN (Q4/2019).
- M3: Phenomenological parametrization of the radiation effects on diodes using the TPATCT method (Q3/2020)